

EXAMINER'S AMENDMENT

The substitute specification filed 29 December 2008 has been found acceptable and has replaced the original specification.

Withdrawn claims 25, 26, 27 & 28 have now been rejoin with elected claims 21 & 40.

An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

Authorization for this examiner's amendment was given in a telephone interview with Jeremy Mereness & Roland Long (Reg No. 41949) on 20 & 25 March 2009.

The application has been amended as follows:

In the Specification:

Page 21, line 5 of the substitute specification, --only-- has been inserted after "and". Page 21, lines 15 & 17 of the substitute specification, "appressed" has been changed to --pressed-- at each occurrence.

In the Claims:

In claim 21, next to last paragraph, first line therein, "having" has been changed to --disposed on--; second line therein, "microstrip line" has been changed to --dielectric material--; second & third lines therein, --and the microstrip line disposed on a side of the dielectric material-- has been inserted between "rod" and "opposite"; third & fourth line therein, "the microstrip line determined as" has been rewritten as --and--; fourth line therein, "with respect to" has been changed to --for the microstrip line defined by--.

In claim 25, line 3, "contact surface of each of" has been rephrased as --respective contact face of--; line 5, "each" has been rephrased as --corresponding ones--; line 8, "surface" has been rewritten as --face--.

In claim 26, line 6, "constituting" has been changed to --of--.

In claim 40, line 5, "connector" has been changed to --conductor--.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Benny Lee whose telephone number is 571 272 1764.

**/BENNY LEE/
PRIMARY EXAMINER
ART UNIT 2817**

B. Lee